


<b>Search Notes</b>  	<b>Application/Control No.</b>  10615088	<b>Applicant(s)/Patent Under Reexamination</b>  YEOH ET AL.
	<b>Examiner</b>  Rashid, David P	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
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382/163 (text search only - see search history printout)	10/29/2007	DPR

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